

MOSFET – Dual, N-Channel, POWERTRENCH®

30 V, 2.9 A, 123 $m\Omega$

FDMA2002NZ

General Description

This device is designed specifically as a single package solution for dual switching requirements in cellular handset and other ultra-portable applications. It features two independent N-Channel MOSFETs with low on-state resistance for minimum conduction losses. The MicroFET $^{\text{M}}$ 2x2 offers exceptional thermal performance for its physical size and is well suited to linear mode applications.

Features

• 2.9 A, 30 V

 $R_{DS(on)} = 123 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$

 $R_{DS(on)} = 140 \text{ m}\Omega$ at $V_{GS} = 3.0 \text{ V}$

 $R_{DS(on)} = 163 \text{ m}\Omega$ at $V_{GS} = 2.5 \text{ V}$

- Low Profile 0.8 mm Maximum In the New Package MicroFET 2x2 mm
- HBM ESD Protection Level > 1.8 kV (Note 3)
- Free from Halogenated Compounds and Antimony Oxides
- This Device is Pb-Free, Halide Free and is RoHS Compliant

V _{DS}	R _{DS(on)} MAX	I _D MAX
30 V	123 mΩ @ 4.5 V	2.9 A
	140 mΩ @ 3.0 V	
	163 mΩ @ 2.5 V	



WDFN6 2x2, 0.65P (MicroFET 2x2) CASE 511DA

MARKING DIAGRAM



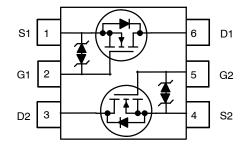
&Z = Assembly Plant Code

&2 = 2-Digit Date Code

&K = 2-Digits Lot Run Traceability Code

002 = Device Code

PIN CONNECTIONS



ORDERING INFORMATION

Device	Package	Shipping [†]
FDMA2002NZ	WDFN6 (Pb-Free, Halide Free)	3000 / Tape & Reel

For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

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ABSOLUTE MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±12	V
Ι _D	Drain Current –Continuous (T_C = 25°C, V_{GS} = 4.5 V) –Continuous (T_C = 25°C, V_{GS} = 2.5 V)	2.9 2.7	Α
	-Pulsed	10	Α
P _D	Power Dissipation for Single Operation (Note 1a) (Note 1b)	1.5 0.65	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	83 (Single Operation)	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1b)	193 (Single Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1c)	68 (Dual Operation)	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1d)	145 (Dual Operation)	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit	
OFF CHAR	OFF CHARACTERISTICS						
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	30	-	-	V	
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C	-	25	-	mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24 V, V _{GS} = 0 V	-	_	1	μΑ	
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$	-	_	±10	μΑ	
ON CHARA	CTERISTICS						
V _{GS(th)}	Gate Threshold Voltage	$I_D = 250 \mu A, V_{DS} = V_{GS}$	0.4	1.0	1.5	٧	
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C	-	-3	-	mV/°C	
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 2.9 \text{ A}$	-	75	123	mΩ	
	On-Resistance	$V_{GS} = 3.0 \text{ V}, I_D = 2.7 \text{ A}$	-	84	140		
		$V_{GS} = 2.5 \text{ V}, I_D = 2.5 \text{ A}$	-	92	163		
		V_{GS} = 4.5 V, I_D = 2.9 A, T_C = 85°C	-	95	166		
		$V_{GS} = 3.0 \text{ V}, I_D = 2.7 \text{ A}, T_C = 150^{\circ}\text{C}$	-	138	203	1	
		$V_{GS} = 2.5 \text{ V}, I_D = 2.5 \text{ A}, T_C = 150^{\circ}\text{C}$	-	150	268	1	
DYNAMIC C	DYNAMIC CHARACTERISTICS						
C _{iss}	Input Capacitance	V _{DS} = 15 V, V _{GS} = 0 V, f = 1.0 MHz	-	190	220	pF	
C _{oss}	Output Capacitance		-	30	40	pF	
C _{rss}	Reverse Transfer Capacitance		-	20	30	pF	

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ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit		
SWITCHING	SWITCHING CHARACTERISTICS (Note 2)							
t _{d(on)}	Turn-On Delay Time	V_{DD} = 15 V, I_{D} = 1 A V_{GS} = 4.5 V, R_{GEN} = 6 Ω	-	6	12	ns		
t _r	Turn-On Rise Time		-	8	16	ns		
t _{d(off)}	Turn-Off Delay Time		-	12	21	ns		
t _f	Turn-Off Fall Time		-	2	10	ns		
Qg	Total Gate Charge	$V_{DS} = 15 \text{ V}, I_D = 2.9 \text{ A}, V_{GS} = 4.5 \text{ V}$	-	2.4	3.0	nC		
Q _{gs}	Gate-Source Charge		-	0.35	_	nC		
Q_{gd}	Gate-Drain Charge		-	0.75	-	nC		

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

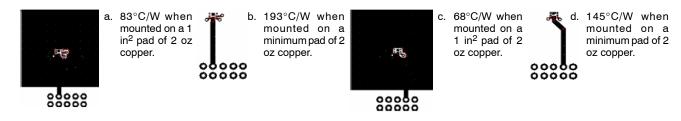
I _S	Maximum Continuous Source-Drain Diode Forward Current		-	ı	2.9	Α
V _{SD}	Source-Drain Diode Forward Voltage I _S = 2.0 A		-	0.9	1.2	V
		I _S = 1.1 A	_	8.0	1.2	
t _{rr}	Diode Reverse Recovery Time $I_F = 2.9 \text{ A}, dI_F/dt = 100 \text{ A}/\mu\text{s}$		_	10	-	ns
Q _{rr}	Diode Reverse Recovery Charge		-	2	_	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

- R_{0JA} is determined with the device mounted on a 1 in² oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while $R_{\theta JA}$ is determined by the user's board design.

 a. $R_{\theta JA} = 83^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For single operation.

 - b. $R_{\theta JA} = 193^{\circ}\text{C/W}$ when mounted on a minimum pad of 2 oz copper. For single operation. c. $R_{\theta JA} = 68^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB. For dual operation.
 - d. $R_{\theta,JA} = 145$ °C/W when mounted on a minimum pad of 2 oz copper. For dual operation.



- 2. Pulse Test: Pulse Width < 300 μs, Duty Cycle < 2.0%
- 3. The diode connected between the gate and source serves only as protection against ESD. No gate overvoltage rating is implied.

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TYPICAL CHARACTERISTICS

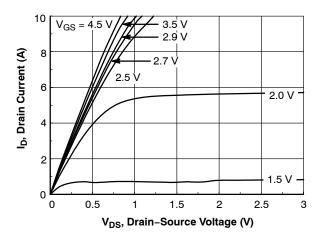


Figure 1. On-Region Characteristics

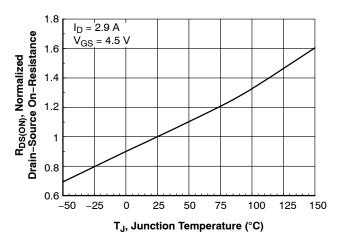


Figure 3. On-Resistance Variation with Temperature

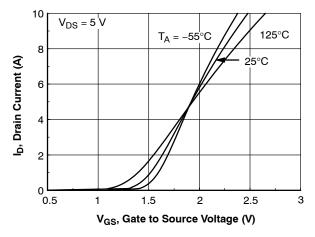


Figure 5. Transfer Characteristics

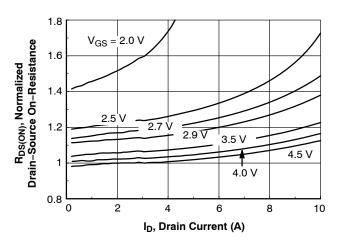


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage

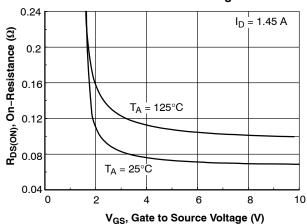


Figure 4. On–Resistance Variation with Gate–to–Source Voltage

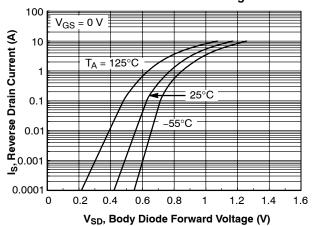


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature

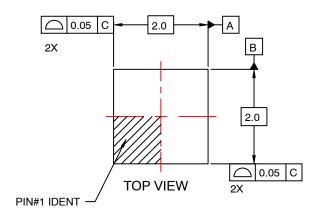
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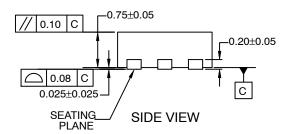
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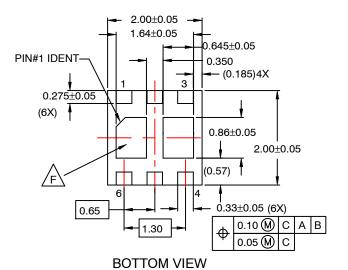


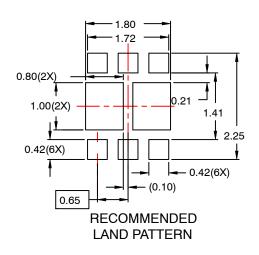
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DATE 31 JUL 2016









NOTES:

- A. CONFORM TO JADEC REGISTRATIONS MO-229, VARIATION VCCC, EXCEPT WHERE NOTED.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.

F. NON-JEDEC DUAL DAP

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